



## 450V N-Channel MOSFET

Lead Free Package and Finish

### General Features

- Proprietary New Planar Technology
- $R_{DS(ON),typ.}=0.30\ \Omega @ V_{GS}=10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

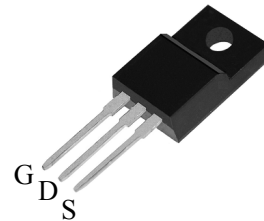
$BV_{DSS}$	$R_{DS(ON),typ.}$	$I_D$
450V	0.30 $\Omega$	13A

### Applications

- Ballast and Lighting
- DC-AC Inverter
- Other Applications

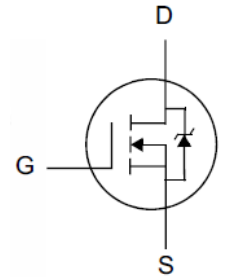
### Ordering Information

Part Number	Package	Brand
PTA13N45	TO-220F	



TO-220F

Package No to Scale



### Absolute Maximum Ratings

 $T_c=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	PTA13N45	Unit
$V_{DSS}$	Drain-to-Source Voltage <sup>[1]</sup>	450	V
$V_{GSS}$	Gate-to-Source Voltage	$\pm 30$	
$I_D$	Continuous Drain Current	13	A
$I_{D@T_c=100^\circ\text{C}}$	Continuous Drain Current @ $T_c=100^\circ\text{C}$	Figure 3	
$I_{DM}$	Pulsed Drain Current at $V_{GS}=10V$ <sup>[2]</sup>	Figure 6	
$E_{AS}$	Single Pulse Avalanche Energy	550	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ <sup>[3]</sup>	5.0	V/ns
$P_D$	Power Dissipation	63	W
	Derating Factor above $25^\circ\text{C}$	0.50	W/ $^\circ\text{C}$
$T_L$ $T_{PAK}$	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	$^\circ\text{C}$
$T_J$ & $T_{STG}$	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

### Thermal Characteristics

Symbol	Parameter	PTA13N45	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.98	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	



## Electrical Characteristics

### OFF Characteristics $T_J = 25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
$BV_{DSS}$	Drain-to-Source Breakdown Voltage	450	--	--	V	$V_{GS}=0V, I_D=250\mu A$
$I_{DSS}$	Drain-to-Source Leakage Current	--	--	1	$\mu A$	$V_{DS}=450V, V_{GS}=0V$
		--	--	100		$V_{DS}=360V, V_{GS}=0V, T_J=125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Leakage Current	--	--	+100	$nA$	$V_{GS}=+30V, V_{DS}=0V$
		--	--	-100		$V_{GS}=-30V, V_{DS}=0V$

### ON Characteristics

$T_J = 25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
$R_{DS(ON)}$	Static Drain-to-Source On-Resistance <sup>[4]</sup>	--	0.30	0.45	$\Omega$	$V_{GS}=10V, I_D=6.5A$
$V_{GS(TH)}$	Gate Threshold Voltage	2.0	--	4.0	V	$V_{DS}=V_{GS}, I_D=250\mu A$
gfs	Forward Transconductance <sup>[4]</sup>	--	22	--	S	$V_{DS}=20V, I_D=13A$

### Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
$C_{iss}$	Input Capacitance	--	1600	--	$pF$	$V_{GS}=0V, V_{DS}=25V, f=1.0MHz$
$C_{rss}$	Reverse Transfer Capacitance	--	16	--		
$C_{oss}$	Output Capacitance	--	150	--		
$Q_g$	Total Gate Charge	--	30	--	$nC$	$V_{DD}=225V, I_D=13A, V_{GS}=0 \text{ to } 10V$
$Q_{gs}$	Gate-to-Source Charge	--	8.0	--		
$Q_{gd}$	Gate-to-Drain (Miller) Charge	--	8.0	--		

### Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
$t_{d(ON)}$	Turn-on Delay Time	--	20	--	$nS$	$V_{DD}=225V, I_D=13A, V_{GS}=10V, R_G=12\Omega$
$t_{rise}$	Rise Time	--	12	--		
$t_{d(OFF)}$	Turn-Off Delay Time	--	80	--		
$t_{fall}$	Fall Time	--	30	--		

**Source-Drain Body Diode Characteristics** $T_J=25^{\circ}\text{C}$  unless otherwise specified

Symbol	Parameter	Min	Typ.	Max.	Unit	Test Conditions
$I_{SD}$	Continuous Source Current <sup>[4]</sup>	--	--	13	A	Integral PN-diode in MOSFET
$I_{SM}$	Pulsed Source Current <sup>[4]</sup>	--	--	52		
$V_{SD}$	Diode Forward Voltage	--	--	1.5	V	$I_S=13\text{A}$ , $V_{GS}=0\text{V}$
trr	Reverse recovery time	--	300	--	ns	$V_{GS}=0\text{V}$ , $I_F=13\text{A}$ , $di_F/dt=100\text{A}/\mu\text{s}$
Qrr	Reverse recovery charge	--	2.5	--	uC	

**Note:**

[1]  $T_J=+25^{\circ}\text{C}$  to  $+150^{\circ}\text{C}$

[2] Repetitive rating; pulse width limited by maximum junction temperature.

[3]  $I_{SD}=13\text{A}$   $di/dt < 100\text{A}/\mu\text{s}$ ,  $V_{DD} < BV_{DSS}$ ,  $T_J=+150^{\circ}\text{C}$ .

[4] Pulse width  $\leq 380\mu\text{s}$ ; duty cycle  $\leq 2\%$ .



### Typical Characteristics

Figure 1. Maximum Effective Thermal Impedance, Junction-to-Case

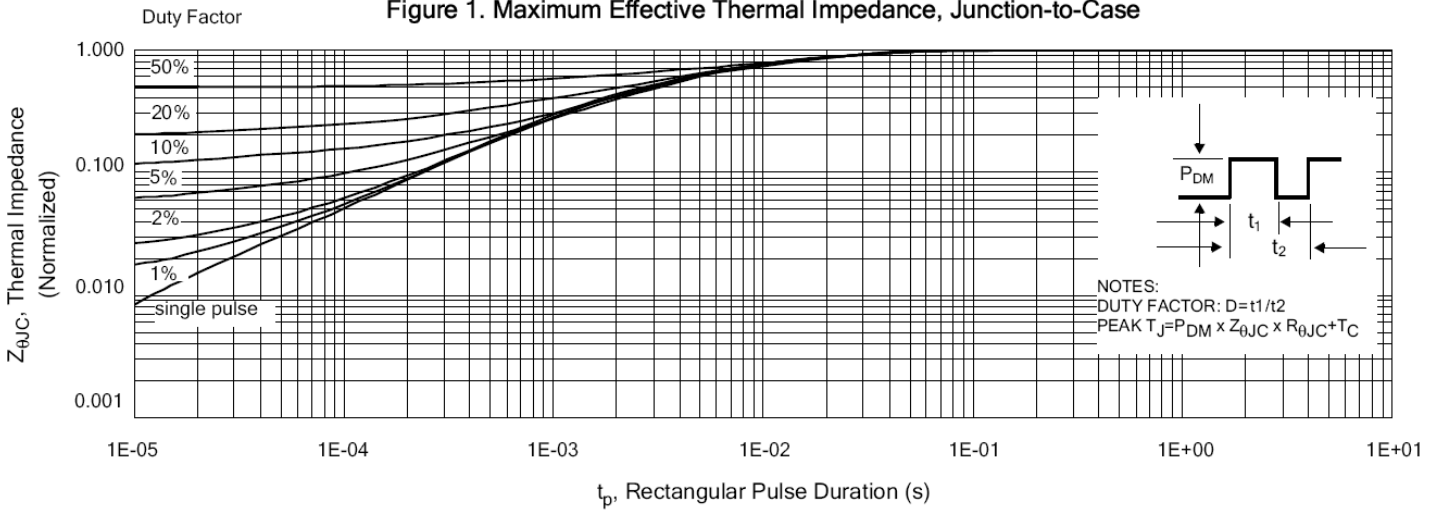


Figure 2 . Max. Power Dissipation vs Case Temperature

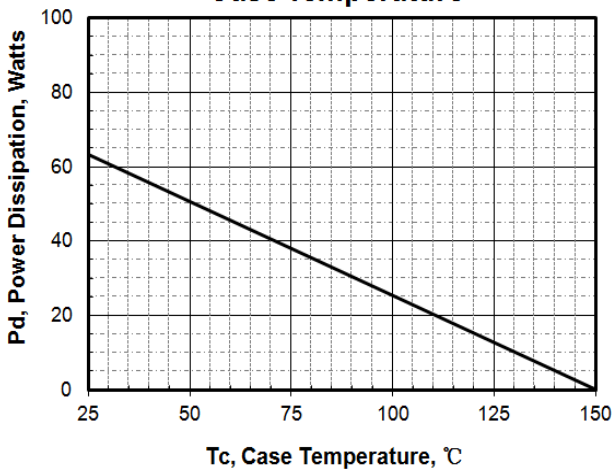


Figure 3 .Maximum Continuous Drain Current vs Tc

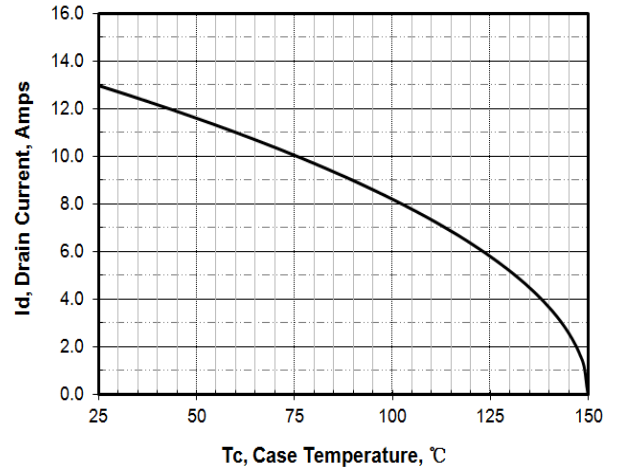


Figure 4. Typical Output Characteristics

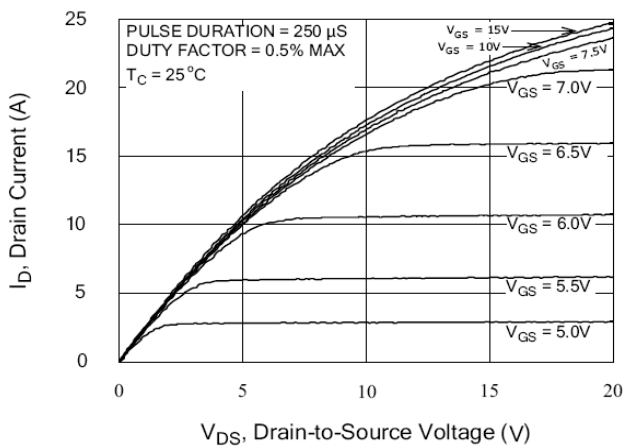
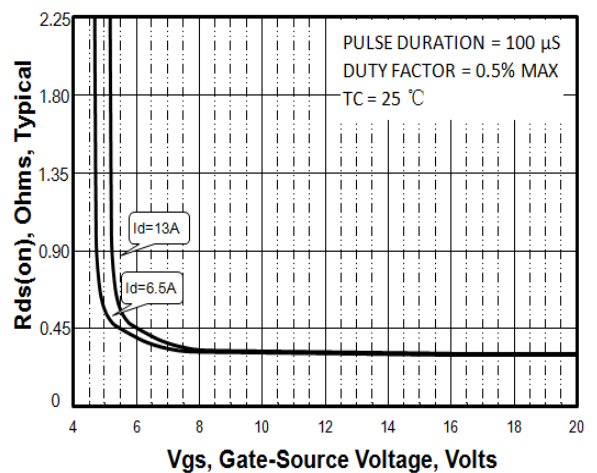


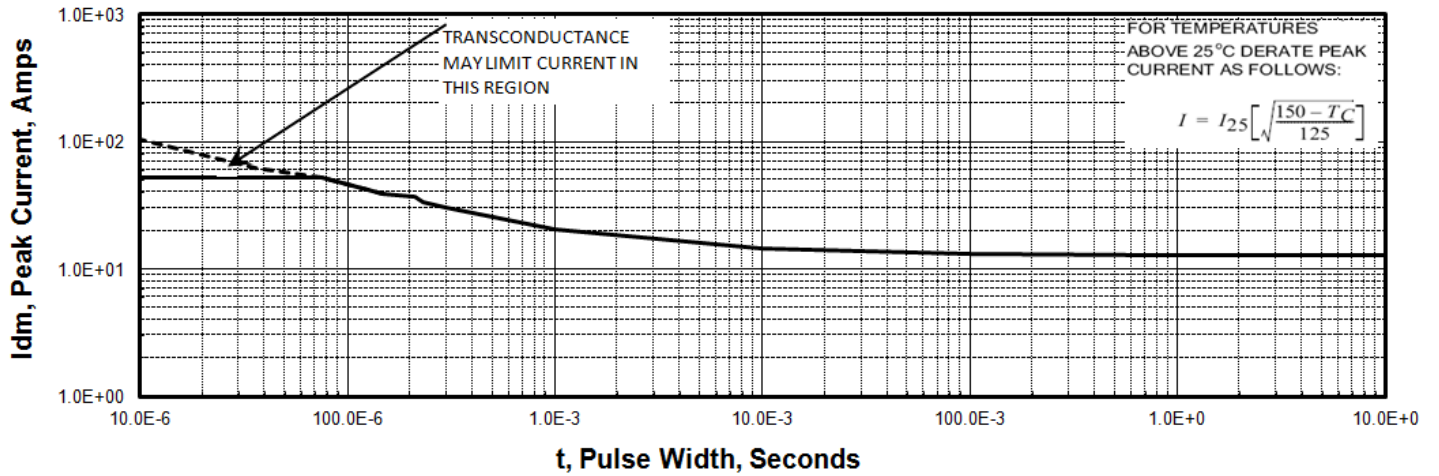
Figure 5. Rdson vs Gate Voltage



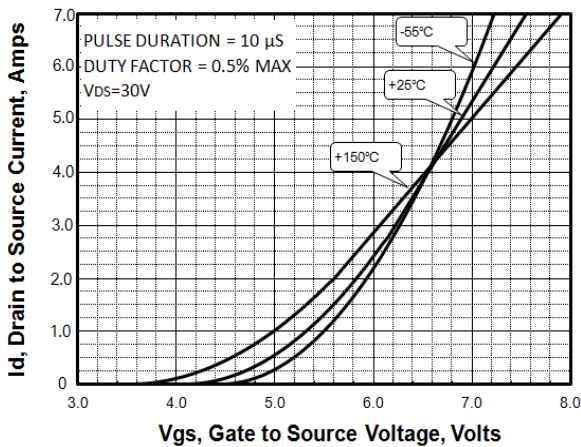


### Typical Characteristics(Cont.)

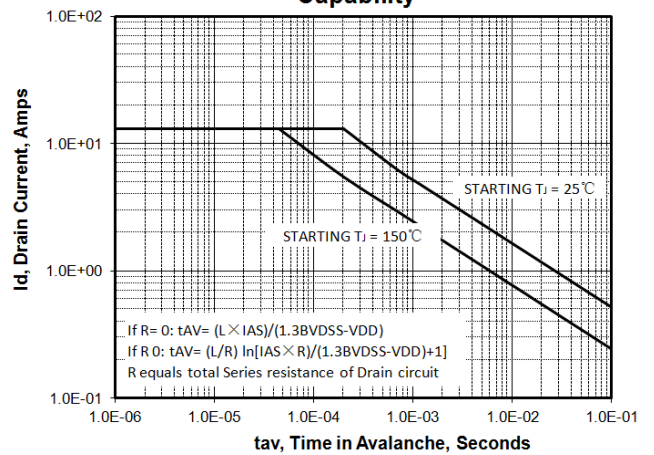
#### Figure 6. Peak Current Capability



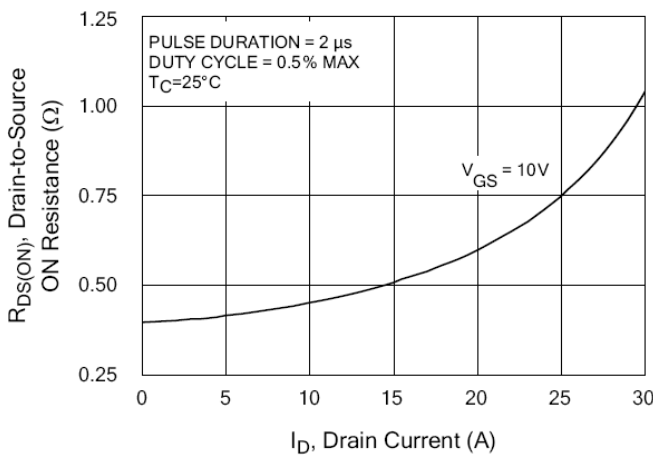
#### Figure 7. Transfer Characteristics



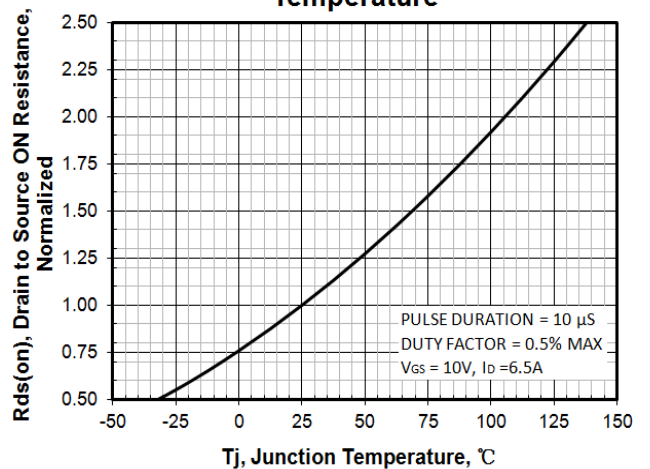
#### Figure 8. Unclamped Inductive Switching Capability



#### Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current



#### Figure 10. Rds(on) vs Junction Temperature





### Typical Characteristics(Cont.)

Figure 11. Typical Breakdown Voltage vs Junction Temperature

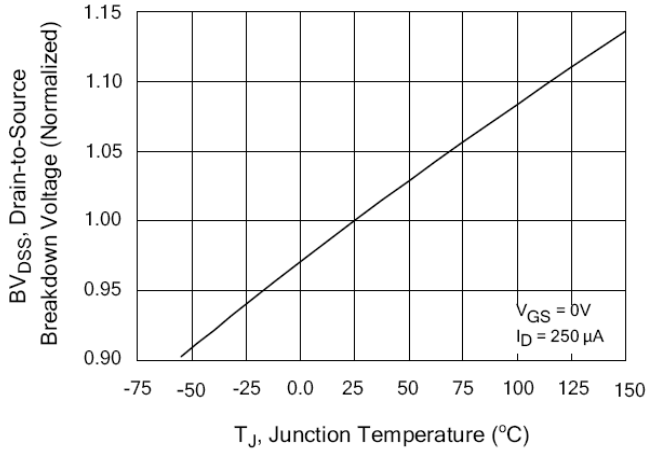


Figure 12. Typical Threshold Voltage vs Junction Temperature

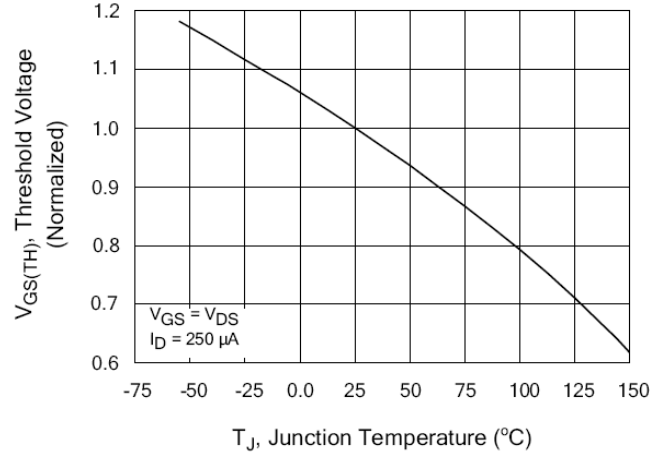


Figure 13 . Maximum Safe Operating Area

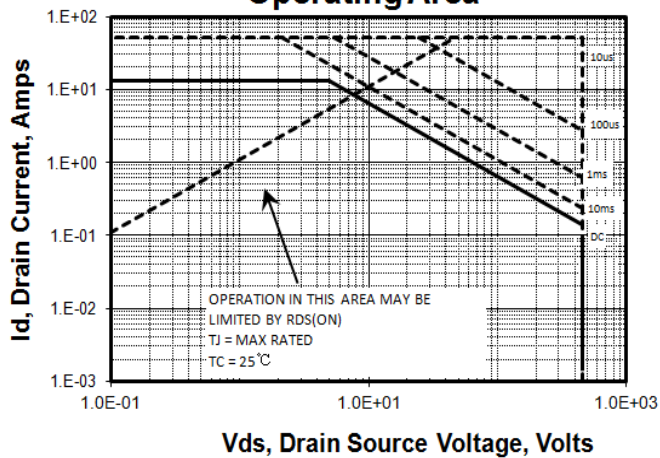


Figure 14. Capacitance vs V<sub>ds</sub>

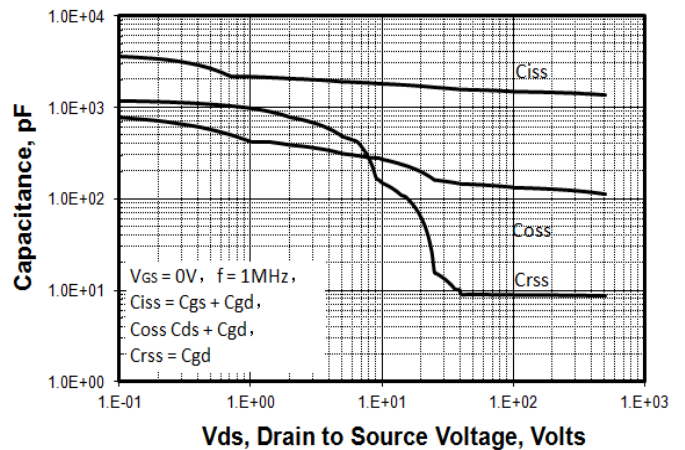


Figure 15 .Typical Gate Charge

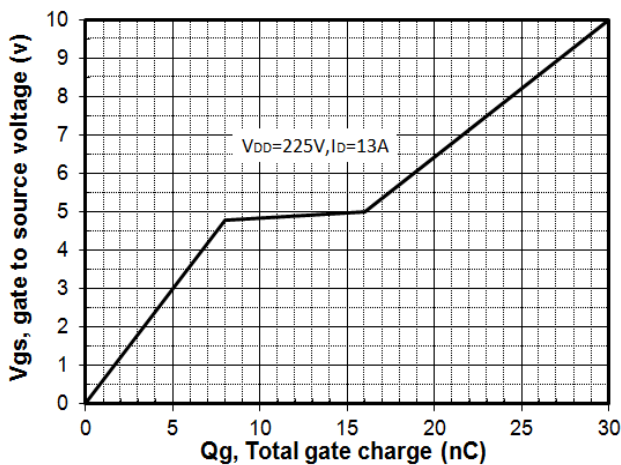
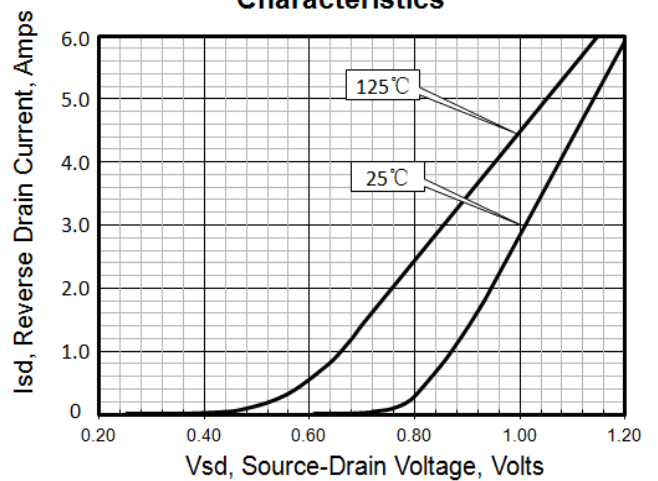


Figure 16.Body Diode Transfer Characteristics





### Test Circuits and Waveforms

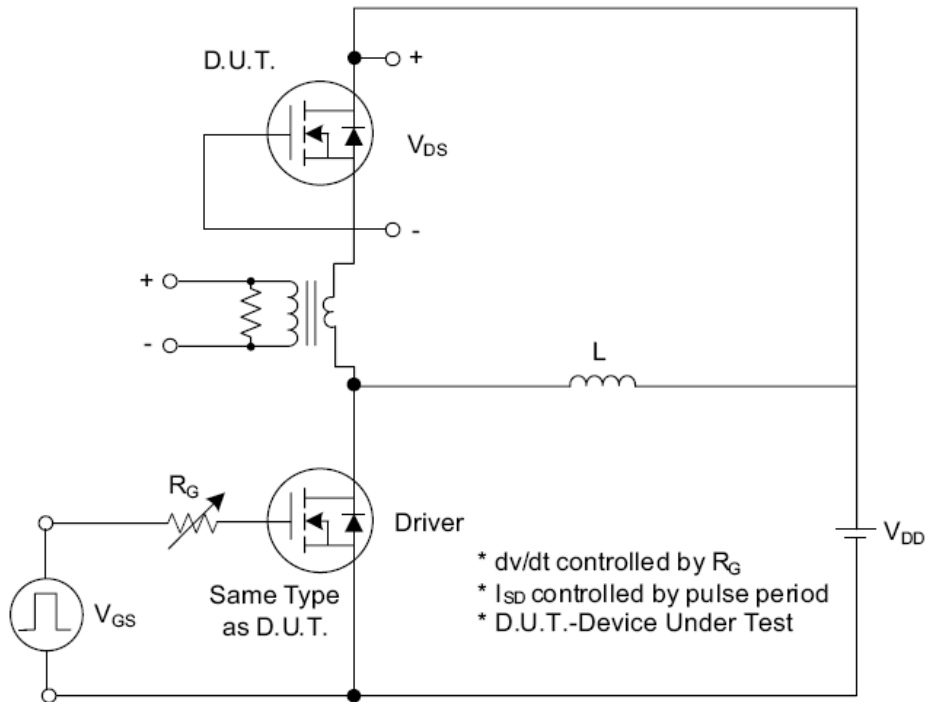


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

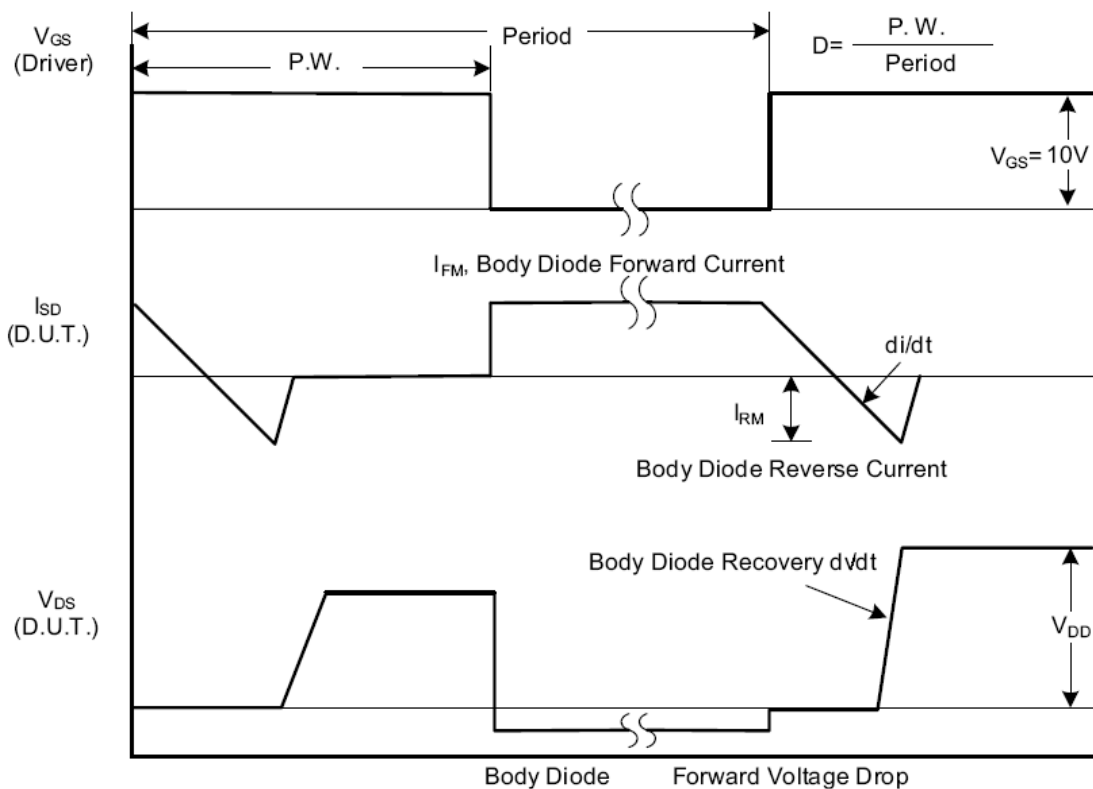


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms

Test Circuits and Waveforms (Cont.)

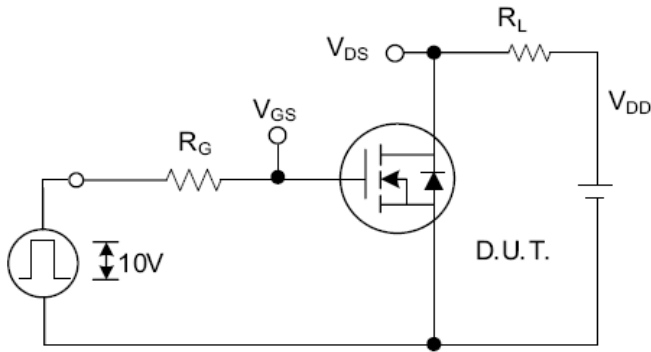


Fig. 2.1 Switching Test Circuit

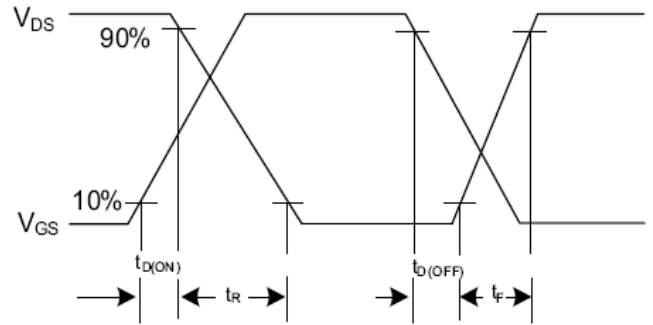


Fig. 2.2 Switching Waveforms

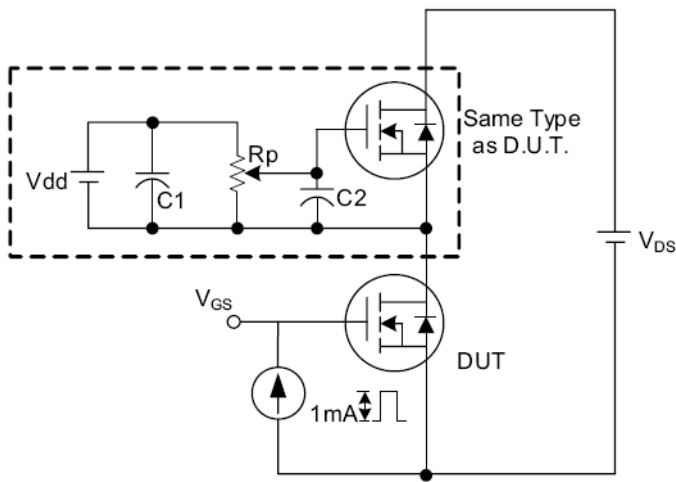


Fig. 3.1 Gate Charge Test Circuit

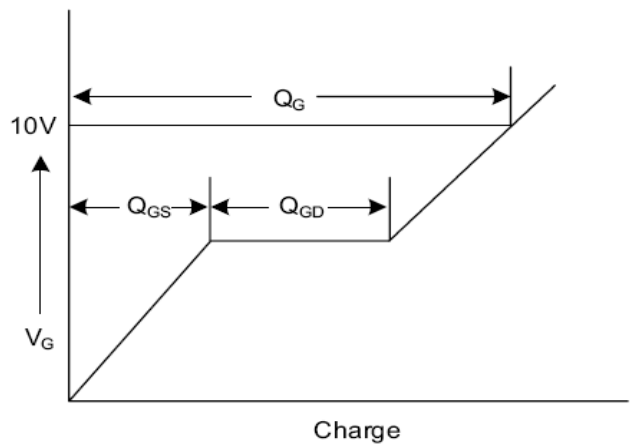


Fig. 3.2 Gate Charge Waveform

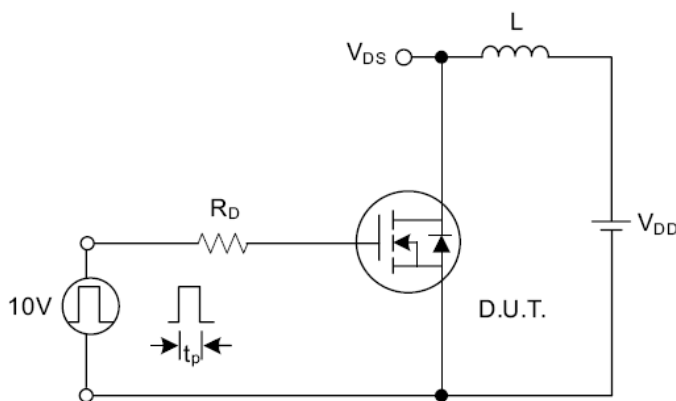


Fig. 4.1 Unclamped Inductive Switching Test Circuit

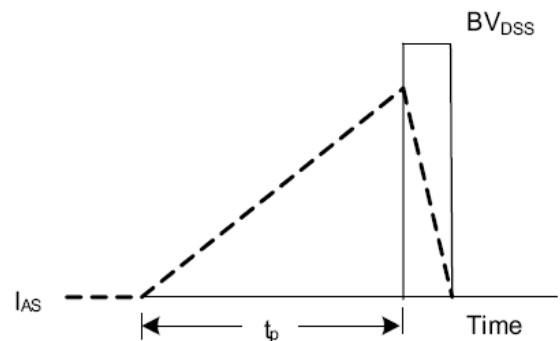


Fig. 4.2 Unclamped Inductive Switching Waveforms





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